# High Speed Communication Circuits and Systems Lecture 7 Noise Modeling in Amplifiers

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#### Notation for Mean, Variance, and Correlation

- Consider random variables x and y with probability density functions f<sub>x</sub>(x) and f<sub>y</sub>(y) and joint probability function f<sub>xy</sub>(x,y)
  - Expected value (mean) of x is

$$\overline{x} = E(x) = \int_{-\infty}^{\infty} x f_x(x) dx$$

- Note: we will often abuse notation and denote  $\overline{x}$  as a random variable (i.e., noise) rather than its mean

The variance of x (assuming it has zero mean) is

$$\overline{x^2} = E(x^*x) = \int_{-\infty}^{\infty} x^* x f_x(x) dx$$

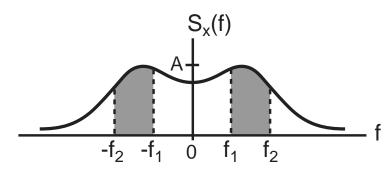
A useful statistic is

$$\overline{xy} = E(xy) = \int_{-\infty}^{\infty} xy f_{xy}(x, y) dx dy$$

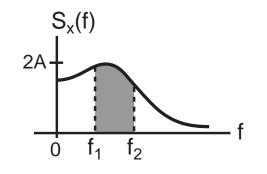
If the above is zero, x and y are said to be uncorrelated

# **Relationship Between Variance and Spectral Density**





**One-Sided Spectrum** 



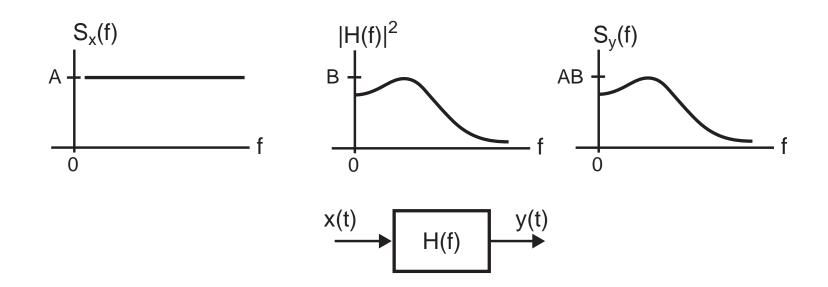
Two-sided spectrum

$$\overline{x^2} = \int_{-f_2}^{-f_1} S_x(f) df + \int_{f_1}^{f_2} S_x(f) df$$

- Since spectrum is symmetric  $\Rightarrow x^2 = 2 \int_{f_1}^{f_2} S_x(f) df$ 

- One-sided spectrum defined over positive frequencies
  - Magnitude defined as twice that of its corresponding two-sided spectrum
- In the next few lectures, we assume a one-sided spectrum for all noise analysis

#### The Impact of Filtering on Spectral Density



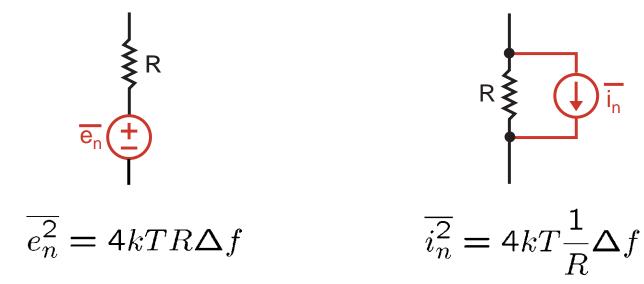
For the random signal passing through a linear, time-invariant system with transfer function H(f)

$$S_y(f) = |H(f)|^2 S_x(f)$$

- We see that if x(t) is amplified by gain A, we have

$$S_y(f) = A^2 S_x(f) \quad \Rightarrow \quad \overline{y^2} = A^2 \overline{x^2}$$

Can be described in terms of either voltage or current



k is Boltzmann's constant

$$k = 1.38 \times 10^{-23} J/K$$

- T is temperature (in Kelvins)
  - Usually assume room temperature of 27 degrees Celsius

$$\Rightarrow T = 300K$$

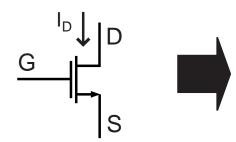
# **Noise In Inductors and Capacitors**

Ideal capacitors and inductors have no noise!



- In practice, however, they will have parasitic resistance
  - Induces noise
  - Parameterized by adding resistances in parallel/series with inductor/capacitor
    - Include parasitic resistor noise sources

# Noise in CMOS Transistors (Assumed in Saturation)



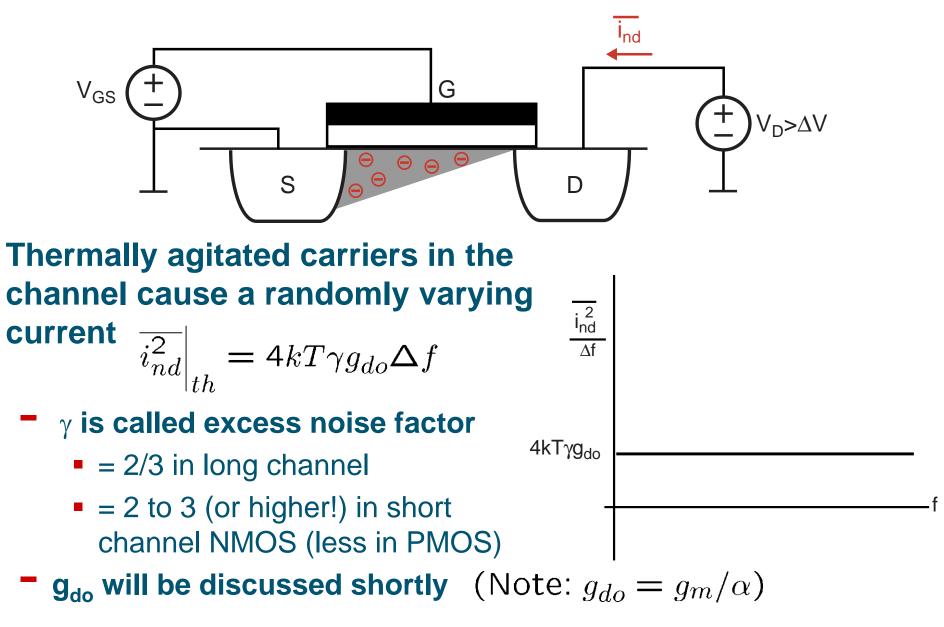
#### **Transistor Noise Sources**

Drain Noise (Thermal and 1/f)

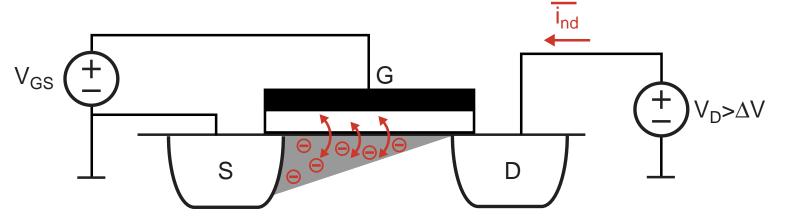
Gate Noise (Induced and Routing Parasitic)

- Modeling of noise in transistors must include several noise sources
  - Drain noise
    - Thermal and 1/f influenced by transistor size and bias
  - Gate noise
    - Induced from channel influenced by transistor size and bias
    - Caused by routing resistance to gate (including resistance of polysilicon gate)
      - Can be made negligible with proper layout such as fingering of devices

# Drain Noise – Thermal (Assume Device in Saturation)



# Drain Noise – 1/f (Assume Device in Saturation)



Traps at channel/oxide interface randomly capture/release carriers

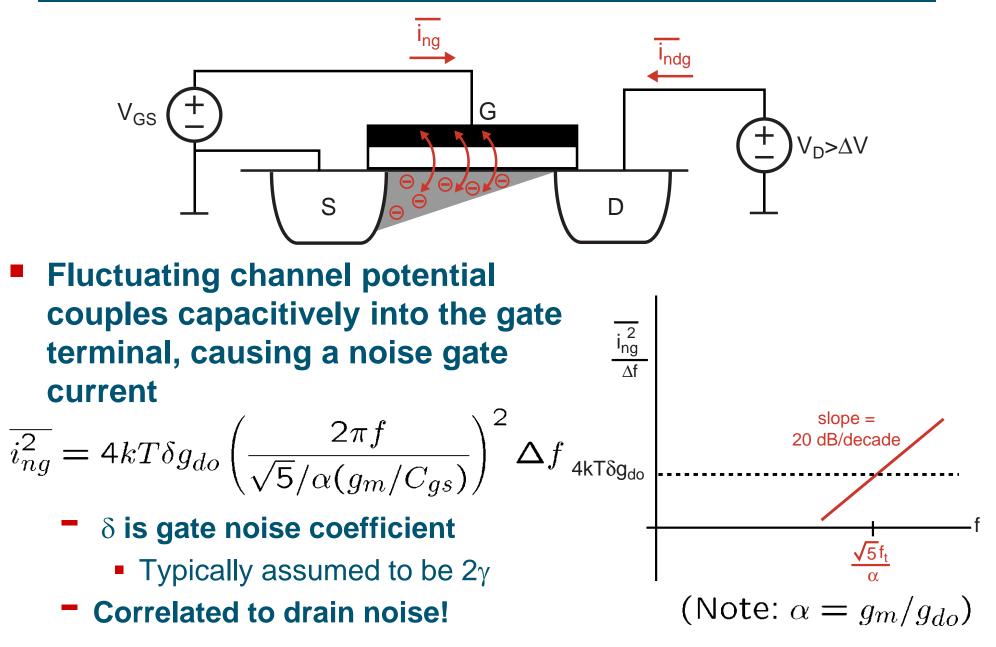
$$\overline{i_{nd}^2}\Big|_{1/f} = \frac{K_f}{f^n} \Delta f \approx \frac{K_f}{f} \frac{g_m^2}{WLC_{ox}^2} \Delta f$$

Parameterized by K<sub>f</sub> and n

- Provided by fab (note n  $\approx$  1)
- Currently: K<sub>f</sub> of PMOS << K<sub>f</sub> of NMOS due to buried channel
- To minimize: want large area (high WL)

 $\frac{i_{nd}^{2}}{\Delta f}$   $4kT\gamma g_{do}$   $\frac{1/f \text{ noise}}{1/f \text{ noise}}$   $\frac{1/f \text{ noise}}{corner \text{ frequency}}$ 

# Induced Gate Noise (Assume Device in Saturation)



### Useful References on MOSFET Noise

- Thermal Noise
  - B. Wang et. al., "MOSFET Thermal Noise Modeling for Analog Integrated Circuits", JSSC, July 1994
- Gate Noise
  - Jung-Suk Goo, "High Frequency Noise in CMOS Low Noise Amplifiers", PhD Thesis, Stanford University, August 2001
    - http://www-tcad.stanford.edu/tcad/pubs/theses/goo.pdf
  - Jung-Suk Goo et. al., "The Equivalence of van der Ziel and BSIM4 Models in Modeling the Induced Gate Noise of MOSFETS", IEDM 2000, 35.2.1-35.2.4
  - Todd Sepke, "Investigation of Noise Sources in Scaled CMOS Field-Effect Transistors", MS Thesis, MIT, June 2002
    - http://www-mtl.mit.edu/research/sodini/sodinitheses.html

### **Drain-Source Conductance:** g<sub>do</sub>

- g<sub>do</sub> is defined as channel resistance with V<sub>ds</sub>=0
  - Transistor in triode, so that

$$I_d = \mu_n C_{ox} \frac{W}{L} \left( (V_{gs} - V_T) V_{ds} - \frac{V_{ds}^2}{2} \right)$$
$$\Rightarrow \left| g_{do} = \frac{dI_d}{dV_{ds}} \right|_{V_{ds}=0} = \mu_n C_{ox} \frac{W}{L} (V_{gs} - V_T)$$

- Equals g<sub>m</sub> for long channel devices
- Key parameters for 0.18µ NMOS devices

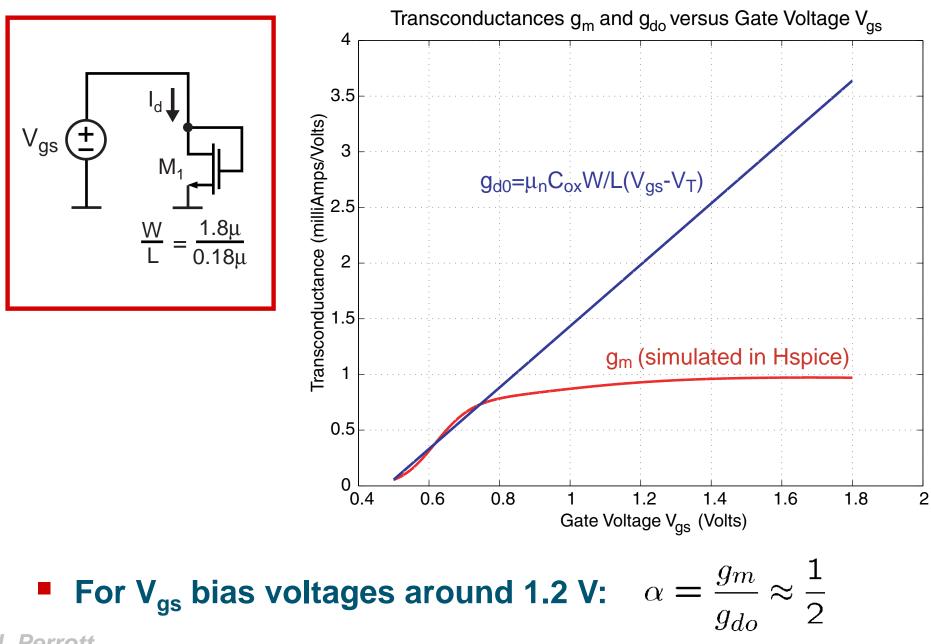
$$\mu_n = 327.4 \text{ cm}^2 / (V \cdot s)$$
  

$$t_{ox} = 4.1 \times 10^{-9} \text{ m} \quad \epsilon_o = 3.9(8.85 \times 10^{-12}) \text{ F/m}$$
  

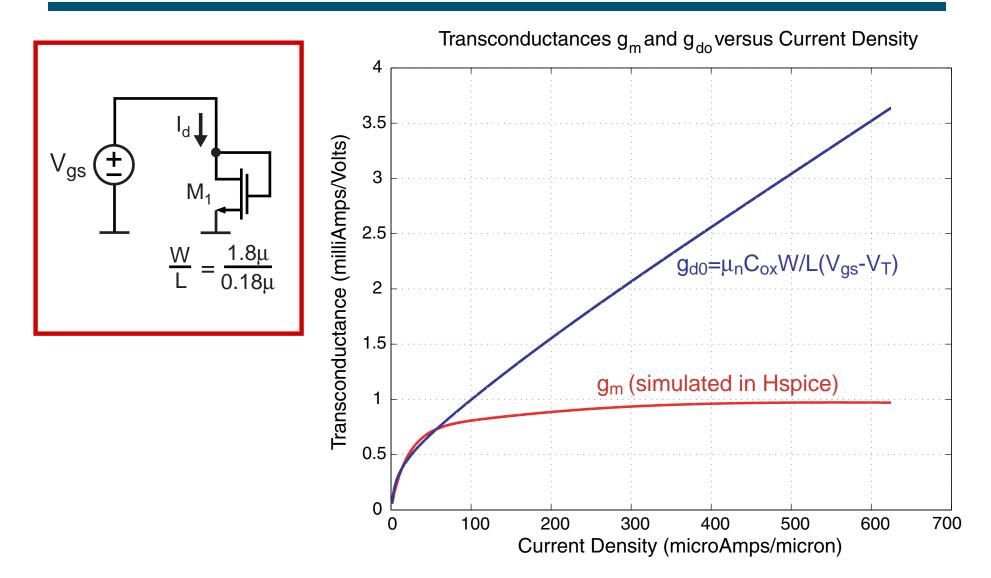
$$\Rightarrow \mu_n C_{ox} = \mu_n \frac{\epsilon_o}{t_{ox}} = 275.6 \times 10^{-6} \text{ F/}(V \cdot s)$$
  

$$V_T = 0.48 \text{ V}$$

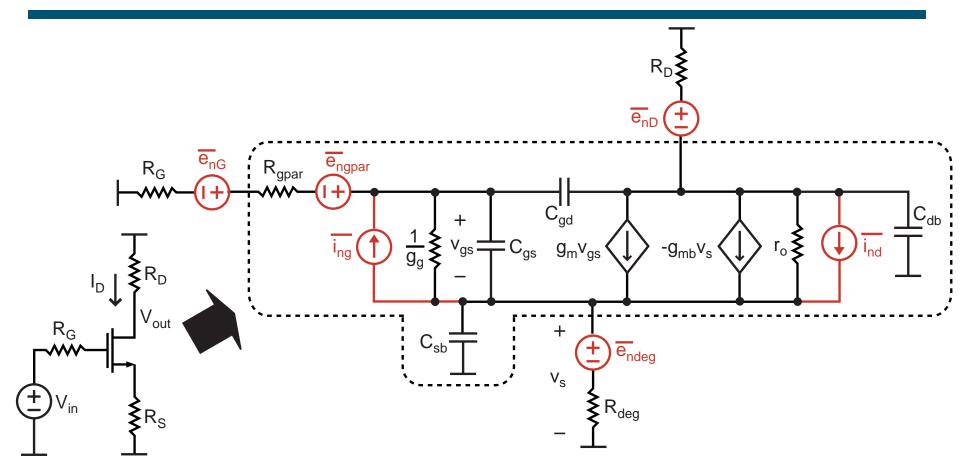
# Plot of $g_m$ and $g_{do}$ versus $V_{gs}$ for 0.18 $\mu$ NMOS Device



# Plot of $g_m$ and $g_{do}$ versus $I_{dens}$ for 0.18 $\mu$ NMOS Device



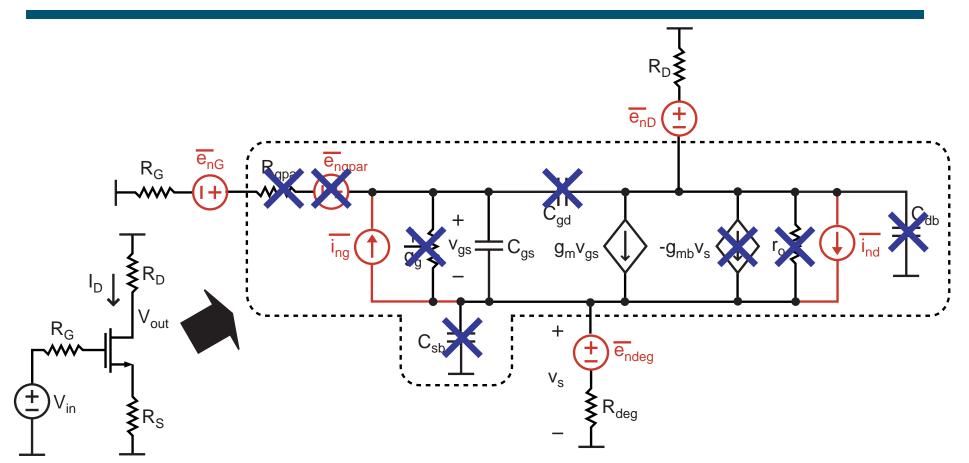
# Noise Sources in a CMOS Amplifier



 $\begin{array}{l} \overline{e_{nG}}, \ \overline{e_{nD}}, \ \overline{e_{ndeg}}: & \text{noise sources of external resistors} \\ R_{gpar}, \ \overline{e_{ngpar}}: & \text{parasitic gate resistance and its noise} \\ \overline{i_{ng}}: & \text{induced gate noise,} \\ g_g: & \text{caused by distributed nature of channel} \\ \left(g_g = \frac{w^2 C_{gs}^2}{5g_{d0}}\right) \\ \overline{f_{nd}}: & \text{drain noise (thermal and 1/f)} \end{array}$ 

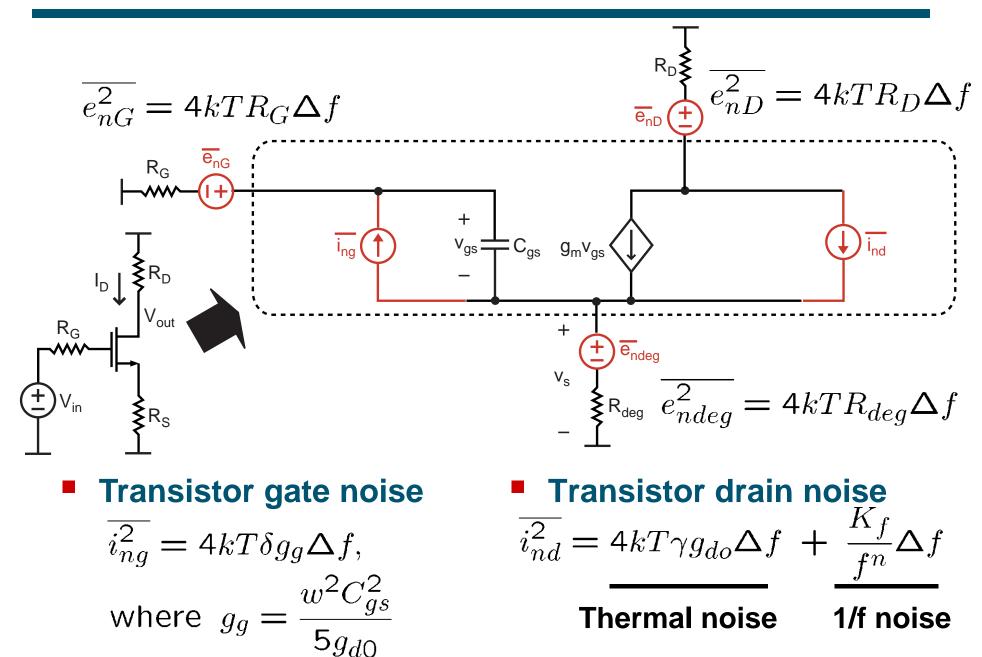
M.H. Perroi

#### **Remove Model Components for Simplicity**

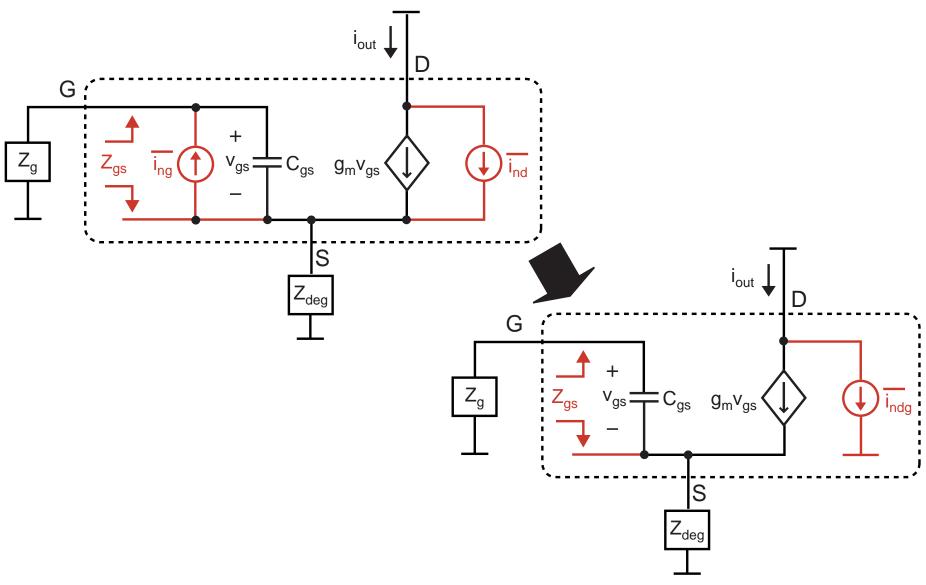


 $R_{gpar}, \ \overline{e_{ngpar}}$ : can make negligible with proper layout  $g_g$ : assume to be neglible (for  $w \ll w_t$ )  $C_{sb}, \ C_{gd}, \ C_{db}, \ g_{mb}$ : too painful to include for calculations  $r_o$ : impact is minor since  $R_D$  is small (for high bandwidth) *M.H. Perrott* 

### Key Noise Sources for Noise Analysis

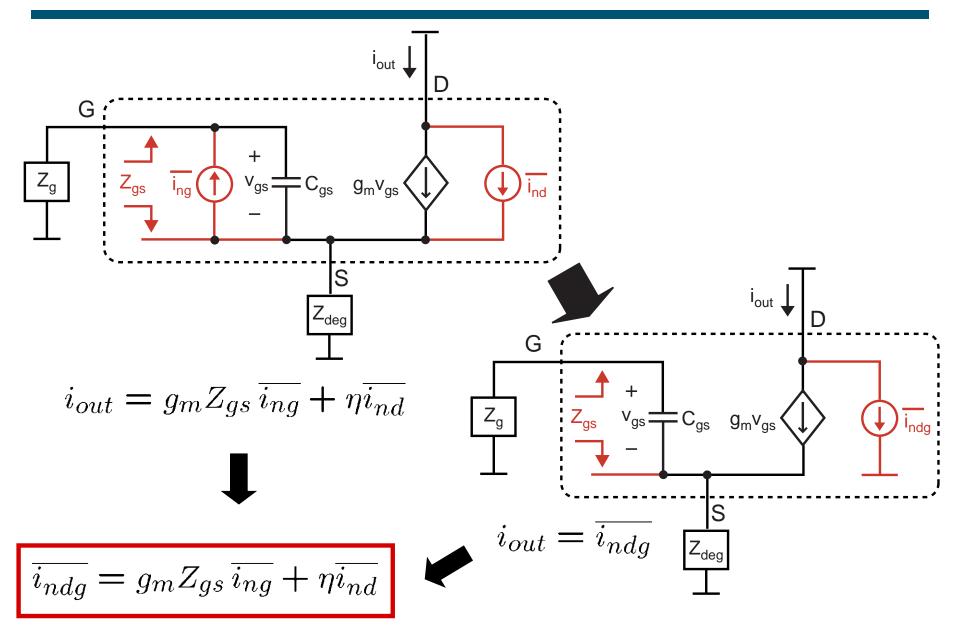


#### Apply Thevenin Techniques to Simplify Noise Analysis

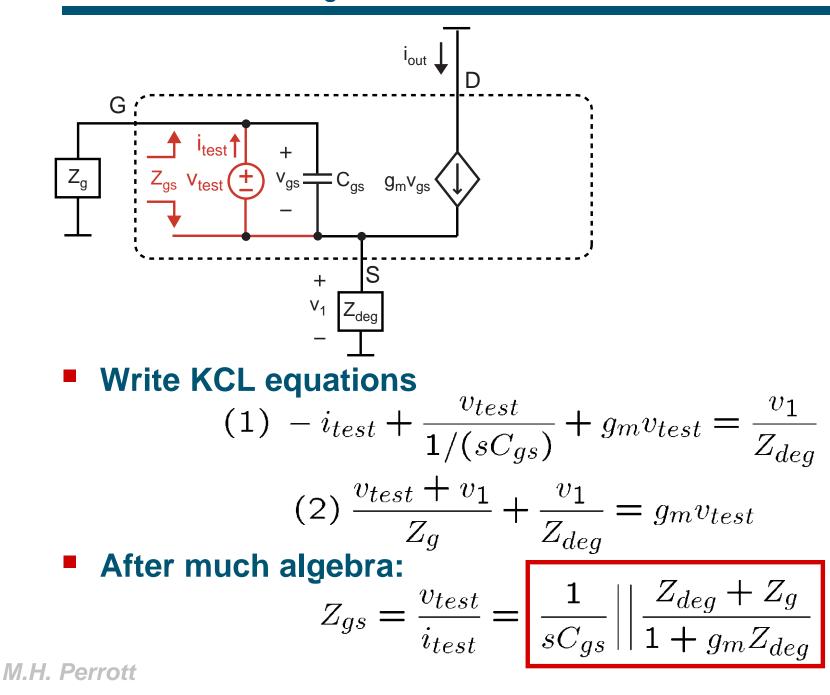


#### Assumption: noise independent of load resistor on drain

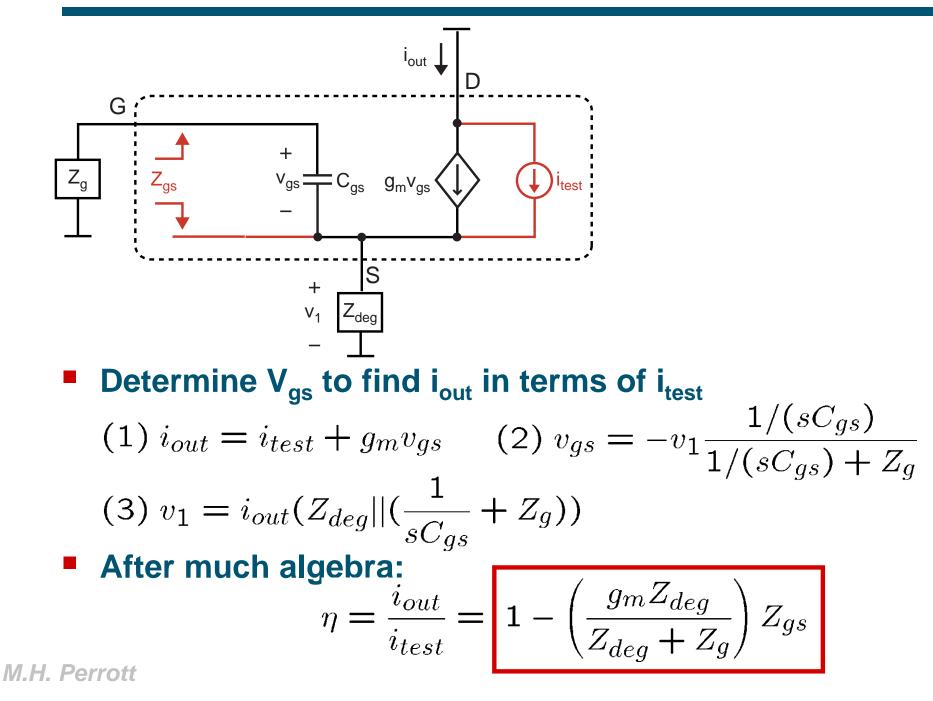
#### **Calculation of Equivalent Output Noise for Each Case**



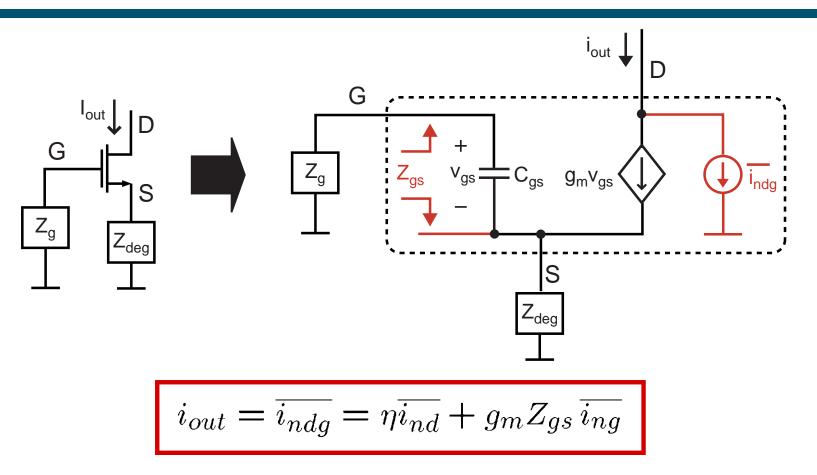
# Calculation of Z<sub>gs</sub>



# Calculation of $\eta$



#### Calculation of Output Current Noise Variance (Power)



#### To find noise variance:

$$i_{ndg}^{2} = \overline{i_{ndg}^{*} i_{ndg}} = \overline{(\eta^{*} i_{nd}^{*} + g_{m} Z_{gs}^{*} i_{ng}^{*})(\eta i_{nd} + g_{m} Z_{gs} i_{ng})}$$

#### Variance (i.e., Power) Calc. for Output Current Noise

#### Noise variance calculation

$$\overline{i_{ndg}^2} = |\eta|^2 \overline{i_{nd}i_{nd}^*} + \overline{i_{nd}^* i_{ng}} g_m \eta^* Z_{gs} + \overline{i_{nd}i_{ng}^*} (g_m \eta Z_{gs})^* + \overline{i_{ng}i_{ng}^*} |g_m Z_{gs}|^2$$

$$= |\eta|^2 \overline{i_{nd}^2} + 2Re\{\overline{i_{nd}^* i_{ng}} g_m \eta^* Z_{gs}\} + \overline{i_{ng}^2} |g_m Z_{gs}|^2$$

$$= |\eta|^2 \overline{i_{nd}^2} + 2Re\{\frac{\overline{i_{nd}^* i_{ng}}}{\sqrt{i_{nd}^2} \overline{i_{ng}^2}} \sqrt{\overline{i_{nd}^2} \overline{i_{ng}^2}} g_m \eta^* Z_{gs}\} + \overline{i_{ng}^2} |g_m Z_{gs}|^2$$

Define correlation coefficient c between i<sub>ng</sub> and i<sub>nd</sub>

$$c = \frac{i_{nd}^* i_{ng}}{\sqrt{i_{nd}^2 \,\overline{i_{ng}^2}}} \Rightarrow \overline{i_{ndg}^2} = |\eta|^2 \overline{i_{nd}^2} + 2Re\{c\sqrt{\overline{i_{nd}^2 \,\overline{i_{ng}^2}}}g_m \eta^* Z_{gs}\} + \overline{i_{ng}^2}|g_m Z_{gs}|^2$$

$$\overline{i_{ndg}^2} = \overline{i_{nd}^2} \left( |\eta|^2 + 2Re \left\{ c \sqrt{\frac{\overline{i_{ng}^2}}{\overline{i_{nd}^2}}} g_m \eta^* Z_{gs} \right\} + \frac{\overline{i_{ng}^2}}{\overline{i_{nd}^2}} g_m^2 |Z_{gs}|^2 \right)$$

# Parameterized Expression for Output Noise Variance

Key equation from last slide

$$\overline{i_{ndg}^2} = \overline{i_{nd}^2} \left( |\eta|^2 + 2Re \left\{ c_{\sqrt{\frac{\overline{i_{ng}}}{\overline{i_{nd}}}}} g_m \eta^* Z_{gs} \right\} + \frac{\overline{i_{ng}}}{\overline{i_{nd}}} g_m^2 |Z_{gs}|^2 \right)$$

Solve for noise ratio

$$\sqrt{\frac{\overline{i_{ng}^2}}{\overline{i_{nd}^2}}}g_m = g_m \sqrt{\frac{4kT\delta(wC_{gs})^2/(5g_{do})}{4kT\gamma g_{do}}} = \frac{g_m}{g_{do}} \sqrt{\frac{\delta}{5\gamma}} (wC_{gs})$$

• Define parameters  $Z_{gsw}$  and  $\chi_d$ 

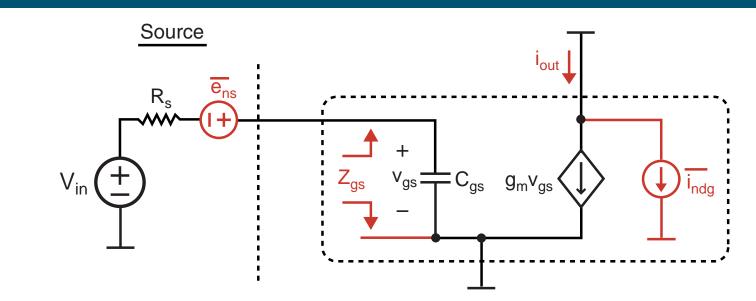
$$Z_{gsw} = wC_{gs}Z_{gs}, \quad \chi_d = \frac{g_m}{g_{do}} \sqrt{\frac{\delta}{5\gamma}}$$

$$\Rightarrow \overline{i_{ndg}^2} = \overline{i_{nd}^2} \left( |\eta|^2 + 2Re \left\{ c\chi_d \eta^* Z_{gsw} \right\} + \chi_d^2 |Z_{gsw}|^2 \right)$$

#### Small Signal Model for Noise Calculations

$$\frac{i_{out} \downarrow p}{\sum_{g} \sum_{Z_{deg}} i_{z_{deg}}} \bigoplus \frac{i_{z_{gs}}^{2} + i_{z_{gs}}^{2} + i_{z_$$

# **Example:** Output Current Noise with $Z_s = R_s$ , $Z_{deg} = 0$



Step 1: Determine key noise parameters

For 0.18µ CMOS, we will assume the following

$$c = -j0.55, \quad \gamma = 3, \quad \delta = 2\gamma = 6, \quad \frac{g_m}{g_{do}} = \frac{1}{2} \Rightarrow \chi_d = 0.32$$

Step 2: calculate η and Z<sub>asw</sub>

$$\eta = 1, \quad Z_{gsw} = wC_{gs} \left( R_s || \frac{1}{jwC_{gs}} \right) = \frac{wC_{gs}R_s}{1 + jwC_{gs}R_s}$$

# **Calculation of Output Current Noise (continued)**

Step 3: Plug values into the previously derived expression

$$\frac{\overline{i_{ndg}^2}}{\Delta f} = \frac{\overline{i_{nd}^2}}{\Delta f} \left( 1 + 2Re \left\{ -j|c|\chi_d Z_{gsw} \right\} + \chi_d^2 |Z_{gsw}|^2 \right)$$
Drain Noise Multiplying Factor
$$Z_{gsw} = wC_{gs} \left( R_s || \frac{1}{jwC_{gs}} \right) = \frac{wC_{gs}R_s}{1 + jwC_{gs}R_s}$$

$$\begin{array}{l} \textbf{For } w << 1/(\textbf{R}_{s}\textbf{C}_{gs}): \\ Z_{gsw} \approx wC_{gs}R_{s} \quad \Rightarrow \quad \frac{\overline{i_{ndg}^{2}}}{\Delta f} \approx \frac{\overline{i_{ndg}^{2}}}{\Delta f} \left(1 + \chi_{d}^{2}(wC_{gs}R_{s})^{2}\right) \end{array}$$

Gate noise contribution

# **Calculation of Output Current Noise (continued)**

Step 3: Plug values into the previously derived expression

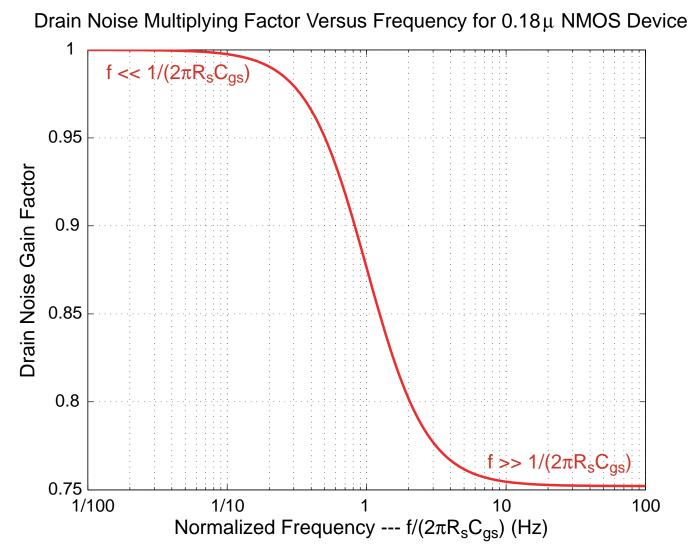
$$\frac{\overline{i_{ndg}^2}}{\Delta f} = \frac{\overline{i_{nd}^2}}{\Delta f} \left( \frac{1 + 2Re \left\{ -j|c|\chi_d Z_{gsw} \right\} + \chi_d^2 |Z_{gsw}|^2 \right)}{\text{Drain Noise Multiplying Factor}} \right)$$
$$Z_{gsw} = wC_{gs} \left( R_s || \frac{1}{jwC_{gs}} \right) = \frac{wC_{gs}R_s}{1 + jwC_{gs}R_s}$$

For w >> 1/(R<sub>s</sub>C<sub>gs</sub>):  

$$Z_{gsw} \approx 1/j \qquad \Rightarrow \quad \frac{\overline{i_{ndg}^2}}{\Delta f} = \frac{\overline{i_{nd}^2}}{\Delta f} \left(1 - \frac{2|c|\chi_d + \chi_d^2}{\Delta f}\right)$$

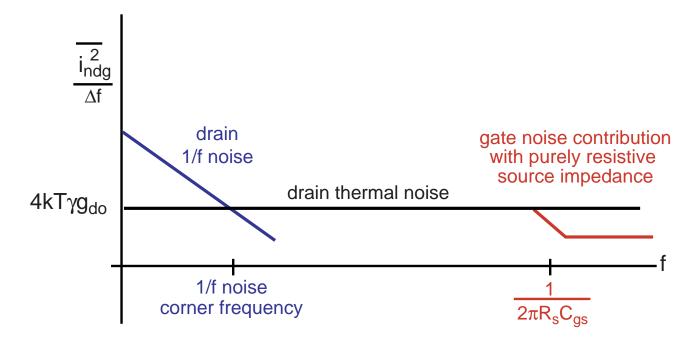
Gate noise contribution

# Plot of Drain Noise Multiplying Factor (0.18µ NMOS)



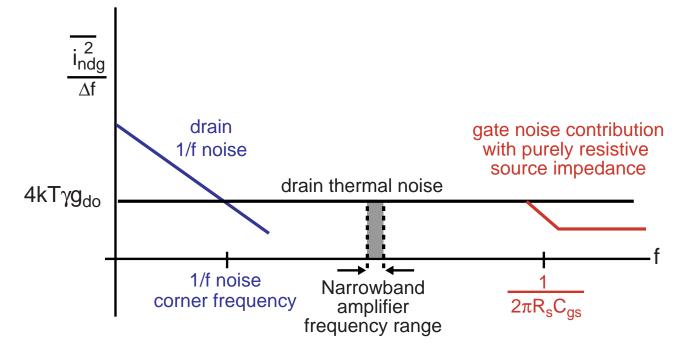
#### Conclusion: gate noise has little effect on common source amp when source impedance is purely resistive!

# **Broadband Amplifier Design Considerations for Noise**



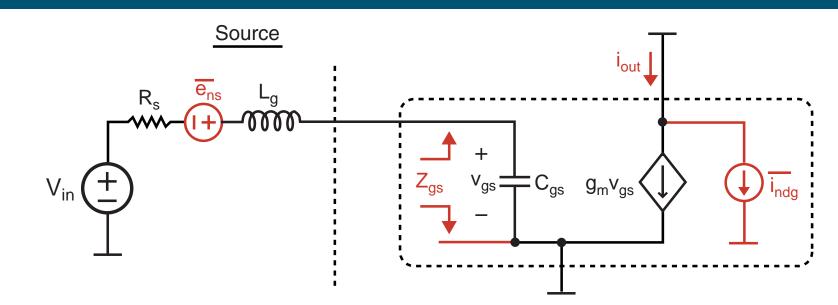
- Drain thermal noise is the chief issue of concern when designing amplifiers with > 1 GHz bandwidth
  - 1/f noise corner is usually less than 1 MHz
  - Gate noise contribution only has influence at high frequencies
- Noise performance specification is usually given in terms of input referred voltage noise

# Narrowband Amplifier Noise Requirements



- Here we focus on a narrowband of operation
  - Don't care about noise outside that band since it will be filtered out
- Gate noise is a significant issue here
  - Using reactive elements in the source dramatically impacts the influence of gate noise
- Specification usually given in terms of Noise Figure M.H. Perrott

#### The Impact of Gate Noise with $Z_s = R_s + sL_q$



Step 1: Determine key noise parameters

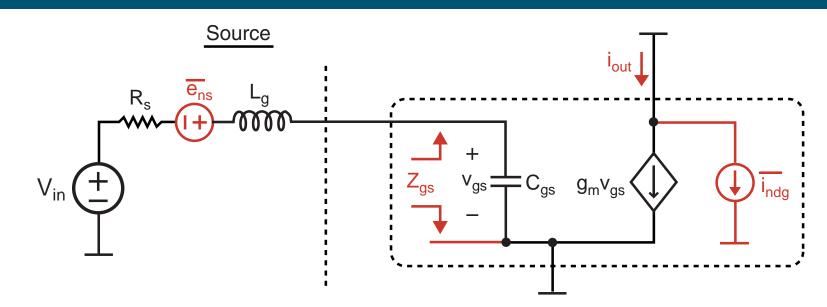
For 0.18µ CMOS, again assume the following

$$c = -j0.55, \quad \gamma = 3, \quad \delta = 2\gamma = 6, \quad \frac{g_m}{g_{do}} = \frac{1}{2} \Rightarrow \chi_d = 0.32$$

Step 2: Note that η =1, calculate Z<sub>gsw</sub>

$$Z_{gsw} = wC_{gs} \left( (R_s + jwL_g) || \frac{1}{jwC_{gs}} \right) = \frac{wC_{gs}(R_s + jwL_g)}{1 - w^2L_gC_{gs} + jwC_{gs}R_s}$$

# Evaluate Z<sub>gsw</sub> At Resonance



Set L<sub>g</sub> such that it resonates with C<sub>gs</sub> at the center frequency (w<sub>o</sub>) of the narrow band of interest

$$\Rightarrow \frac{1}{\sqrt{L_g C_{gs}}} = w_o \qquad \text{Note: } Q = \frac{1}{w_o C_{gs} R_s} = \frac{w_o L_g}{R_s}$$

• Calculate  $Z_{gsw}$  at frequency  $w_o$  $Z_{gsw} = \frac{w_o C_{gs}(R_s + jw_o L_g)}{1 - w_o^2 L_g C_{gs} + jw_o C_{gs} R_s} = w_o C_{gs}(Q^2 R_s - j\sqrt{L_g/C_{gs}})$  = Q - jM.H. Perrott The Impact of Gate Noise with  $Z_s = R_s + sL_g$  (Cont.)

Key noise expression derived earlier

$$\frac{i_{ndg}^2}{\Delta f} = \frac{\overline{i_{nd}^2}}{\Delta f} \left( 1 + 2Re \left\{ -j|c|\chi_d Z_{gsw} \right\} + \chi_d^2 |Z_{gsw}|^2 \right)$$

Substitute in for Z<sub>gsw</sub>

$$2Re \{-j|c|\chi_d Z_{gsw}\} = 2Re \{-j|c|\chi_d (Q-j)\} = -2|c|\chi_d$$

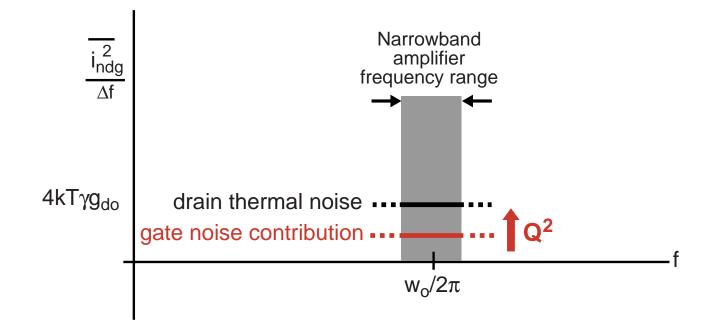
$$\chi_d^2 |Z_{gsw}|^2 = \chi_d^2 |Q - j|^2 = \chi_d^2 (Q^2 + 1)$$

$$\Rightarrow \frac{\overline{i_{ndg}^2}}{\Delta f} = \frac{\overline{i_{nd}^2}}{\Delta f} \left( 1 - 2|c|\chi_d + \chi_d^2(Q^2 + 1) \right)$$
  
Gate noise contribution

#### Gate noise contribution is a function of Q!

Rises monotonically with Q

#### At What Value of Q Does Gate Noise Exceed Drain Noise?

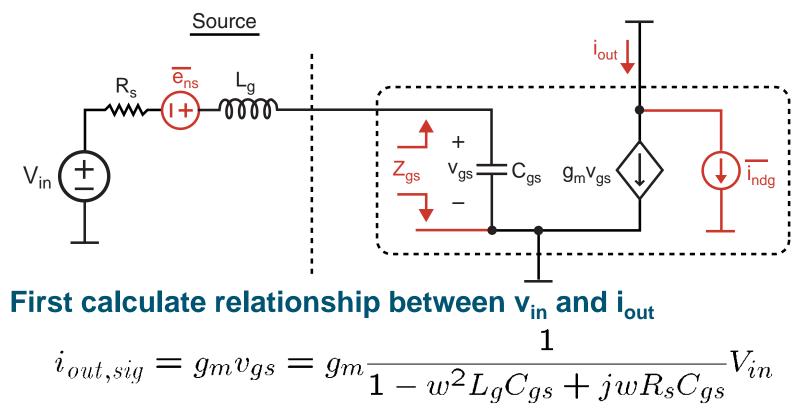


Determine crossover point for Q value

$$\begin{aligned} \overline{i_{ndg}^2} &= \frac{\overline{i_{nd}^2}}{\Delta f} \left(1 - 2|c|\chi_d + \chi_d^2(Q^2 + 1)\right) = \frac{\overline{i_{nd}^2}}{\Delta f} 1\\ \Rightarrow \ Q &= \sqrt{1/\chi_d^2 - 1 + 2|c|/\chi_d} \ (= 3.5 \text{ for } 0.18\mu \text{ specs}) \end{aligned}$$

#### Critical Q value for crossover is primarily set by process

#### Calculation of the Signal Spectrum at the Output



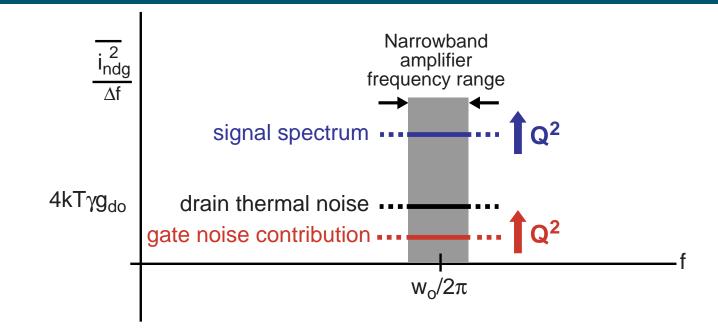
At resonance:

$$i_{out,sig} = g_m v_{gs} = g_m \frac{1}{jw_o R_s C_{gs}} v_{in} = g_m (-jQ) v_{in}$$

Spectral density of signal at output at resonant frequency

$$S_{iout,sig}(f) = |g_m(-jQ)|^2 S_{in}(f) = (g_mQ)^2 S_{in}(f)$$

# Impact of Q on SNR (Ignoring R<sub>s</sub> Noise)



SNR (assume constant spectra, ignore noise from R<sub>s</sub>):

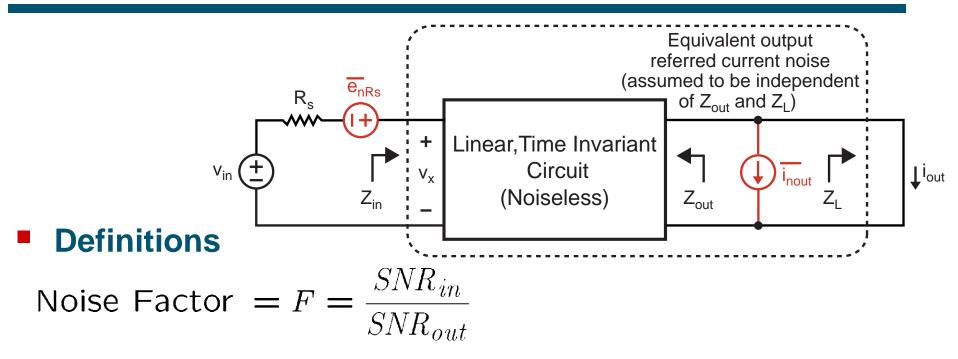
$$SNR_{out} = \frac{S_{iout,sig}(f)}{S_{iout,noise}(f)} \approx \frac{(g_m Q)^2 S_{in}(f)}{\overline{i_{ndg}^2}/\Delta f}$$

For small Q such that gate noise < drain noise</p>

SNR<sub>out</sub> improves dramatically as Q is increased

- For large Q such that gate noise > drain noise
  - **SNR**<sub>out</sub> improves very little as Q is increased

# Noise Factor and Noise Figure

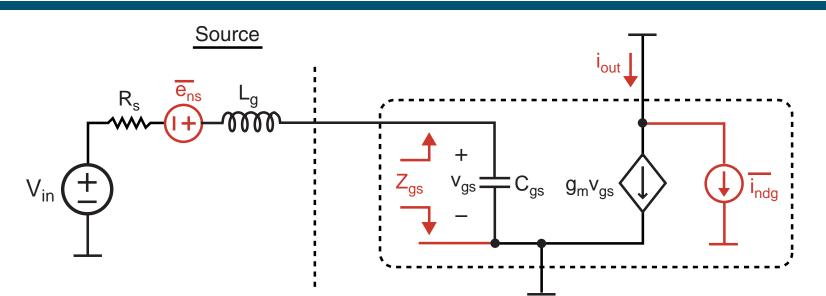


Noise Figure =  $10 \log(Noise Factor)$ 

Calculation of SNR<sub>in</sub> and SNR<sub>out</sub>

$$SNR_{in} = \frac{|\alpha|^2 v_{in}^2}{|\alpha|^2 \overline{e_{nRs}^2}} = \frac{v_{in}^2}{\overline{e_{nRs}^2}} \quad \text{where } \alpha = \frac{Z_{in}}{R_s + Z_{in}}$$
$$SNR_{out} = \frac{|\alpha|^2 |G_m|^2 v_{in}^2}{|\alpha|^2 |G_m|^2 \overline{e_{nRs}^2} + \overline{i_{nout}^2}} \quad \text{where } G_m = \frac{i_{out}}{v_x}$$

## Calculate Noise Factor (Part 1)



First calculate SNR<sub>out</sub> (must include R<sub>s</sub> noise for this)

R<sub>s</sub> noise calculation (same as for V<sub>in</sub>)

$$i_{out,Rs} = g_m(-jQ) \overline{e_{ns}} \Rightarrow S_{iout,Rs}(f) = (g_mQ)^2 4kTR_s$$
  
- SNR<sub>out</sub>: 
$$\Rightarrow SNR_{out} = \frac{(g_mQ)^2 S_{in}(f)}{\frac{i_{ndg}^2}{\Delta f} + (g_mQ)^2 4kTR_s}$$
  
Then calculate SNR<sub>in</sub>: 
$$SNR_{in} = \frac{S_{in}(f)}{\frac{e_{ns}^2}{\Delta f}} = \frac{S_{in}(f)}{4kTR_s}$$

#### **Calculate Noise Factor (Part 2)**

$$SNR_{out} = \frac{|g_m Q|^2 S_{in}(f)}{\overline{i_{ndg}^2}/\Delta f + (g_m Q)^2 4kTR_s} \quad SNR_{in} = \frac{S_{in}(f)}{\overline{e_{ns}^2}/\Delta f} = \frac{S_{in}(f)}{4kTR_s}$$

#### Noise Factor calculation:

Noise Factor 
$$= \frac{SNR_{in}}{SNR_{out}} = \frac{i_{ndg}^2 / \Delta f + |g_m Q|^2 4kTR_s}{(g_m Q)^2 4kTR_s}$$
  
 $= 1 + \frac{\overline{i_{ndg}^2} / \Delta f}{(g_m Q)^2 4kTR_s}$   
From previous analysis

$$\overline{i_{ndg}^2}/\Delta f = 4kT\gamma g_{do}\left(1-2|c|\chi_d+(Q^2+1)\chi_d^2\right)$$

$$\Rightarrow \text{ Noise Factor} = 1 + \frac{\gamma g_{do} \left(1 - 2|c|\chi_d + (Q^2 + 1)\chi_d^2\right)}{(g_m Q)^2 R_s}$$
*M.H. Perrott*

#### **Calculate Noise Factor (Part 3)**

Noise Factor = 
$$1 + \frac{\gamma g_{do} \left(1 - 2|c|\chi_d + (Q^2 + 1)\chi_d^2\right)}{(g_m Q)^2 R_s}$$

Modify denominator using expressions for Q and w<sub>t</sub>

$$Q = \frac{1}{w_o R_s C_{gs}}, \quad w_t \approx \frac{g_m}{C_{gs}}$$
$$\Rightarrow \quad (g_m Q)^2 R_s = g_m^2 Q \frac{R_s}{w_o R_s C_g s} = g_m Q \frac{g_m}{C_{gs}} \frac{1}{w_o} = g_m Q \frac{w_t}{w_o}$$

Resulting expression for noise factor:

Noise Factor = 
$$1 + \left(\frac{w_o}{w_t}\right) \gamma \left(\frac{g_{do}}{g_m}\right) \frac{1}{Q} \left(1 - 2|c|\chi_d + (Q^2 + 1)\chi_d^2\right)$$

**Noise Factor scaling coefficient** 

Noise factor primarily depends on Q, w<sub>o</sub>/w<sub>t</sub>, and process specs

Noise Factor = 
$$1 + \left(\frac{w_o}{w_t}\right) \gamma \left(\frac{g_{do}}{g_m}\right) \frac{1}{Q} \left(1 - 2|c|\chi_d + (Q^2 + 1)\chi_d^2\right)$$

**Noise Factor scaling coefficient** 

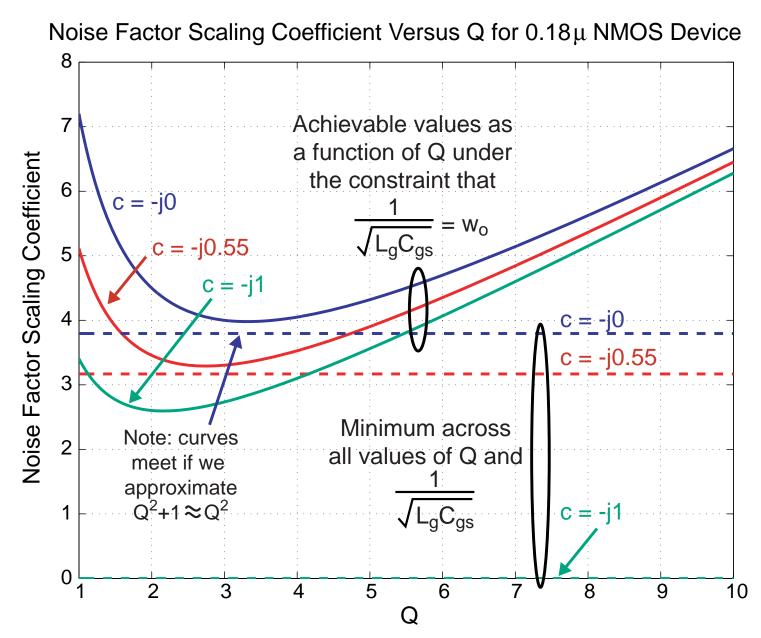
- We see that the noise factor will be minimized for some value of Q
  - Could solve analytically by differentiating with respect to Q and solving for peak value (i.e. where deriv. = 0)
- In Tom Lee's book (pp 272-277), the minimum noise factor for the MOS common source amplifier (i.e. no degeneration) is found to be:

Min Noise Factor = 
$$1 + \left(\frac{w_o}{w_t}\right) \frac{2}{\sqrt{5}} \sqrt{\gamma \delta(1 - |c|^2)}$$

**Noise Factor scaling coefficient** 

#### How do these compare?

#### Plot of Minimum Noise Factor and Noise Factor Vs. Q



# Achieving Minimum Noise Factor

- For common source amplifier without degeneration
  - Minimum noise factor can only be achieved at resonance if gate noise is uncorrelated to drain noise (i.e., if c = 0) we'll see this next lecture
  - We typically must operate slightly away from resonance in practice to achieve minimum noise factor since c will be nonzero
- How do we determine the optimum source impedance to minimize noise figure in classical analysis?
  - Next lecture!